

# SP724 Series

## 3pF 8kV Diode Array



### Additional Information



Resources

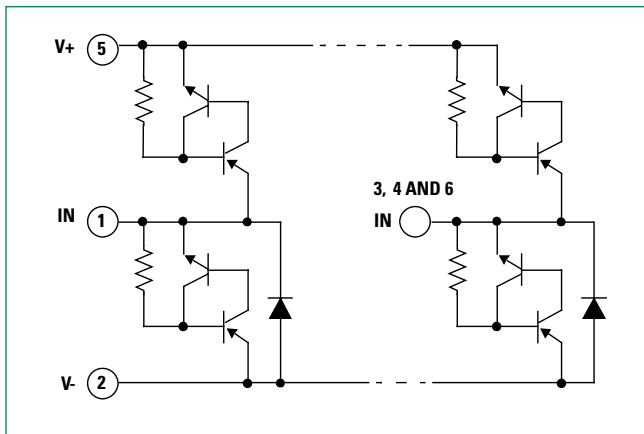


Accessories



Samples

### Functional Block Diagram



#### Notes:

- The design of the SP724 SCR/Diode ESD Protection Arrays are covered by Littelfuse patent 4567500.
- The full ESD capability of the SP724 is achieved when wired in a circuit that includes connection to both the V+ and V- pins. When handling individual devices, follow proper procedures for electrostatic discharge.

#### Life Support Note:

Not Intended for Use in Life Support or Life Saving Applications  
The products shown herein are not designed for use in life sustaining or life saving applications unless otherwise expressly indicated.

### Description

The SP724 is a quad array of transient voltage clamping circuits designed to suppress ESD and other transient over-voltage events. The SP724 is used to help protect sensitive digital or analog input circuits on data, signal, or control lines operating on power supplies up to 20VDC.

The SP724 is comprised of bipolar SCR/diode structures to protect up to four independent lines by clamping transients of either polarity to the power supply rails. The SP724 offers very low leakage (1nA Typical) and low input capacitance (3pF Typical). Additionally, the SP724 is rated to withstand the IEC 61000-4-2 ESD specification for both contact and air discharge methods to level 4.

The SP724 is connected to the sensitive input line and its associated power supply lines. Clamping action occurs during the transient pulse, turning on the diode and fast triggering SCR structures when the voltage on the input line exceeds one  $V_{BE}$  threshold above the V+ supply (or one  $V_{BE}$  threshold below the V- supply). Therefore, the SP724P operation is unaffected by poor power supply regulation or voltage fluctuations within its operating range.

### Features & Benefits

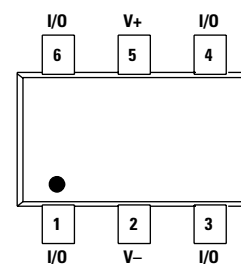
- An Array of 4 SCR/Diode Pairs in 6-Lead SOT-23
- ESD Capability per HBM Standards
  - IEC 61000-4-2, Direct Discharge 8kV (Level 4)
  - IEC 61000-4-2, Air Discharge 15kV (Level 4)
  - MIL STD 3015.7 >8kV
- Input Protection for Applications with Power Supplies Up to +20V (Single-Ended Voltage), and ±10V (Differential Voltage)
- Peak Current Capability
  - IEC 61000-4-5 (8/20µs) ±3A
  - Single Pulse, 100µs Pulse Width ±2.2A
- Low Input Leakage 1nA Typical
- Low Input Capacitance 3pF Typical
- Operating Temperature Range -40°C to 105°C

### Applications

- Microprocessor/Logic Input Protection
- Analog Device Input Protection
- Data Bus Protection
- Voltage Clamp

### Pinout

SP724  
(SOT-23)  
TOP VIEW



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### Absolute Maximum Ratings

Parameter	Rating	Units
Continuous Supply Voltage, (V+) - (V-)	+20	V
Forward Peak Current, $I_{IN}$ to $V_{CC}$ , GND (Refer to Figure 5)	$\pm 2.2$ , 100 $\mu$ s	A

**Caution:** Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

**Note:** ESD Ratings and Capability - See Figure 1, Table 1

### Thermal Information

Parameter	Rating	Units
Thermal Resistance (Typical, Note 3)	$\theta_{JA}$	$^{\circ}$ C/W
SOT Package	220	$^{\circ}$ C/W
Maximum Storage Temperature Range	-65 to 150	$^{\circ}$ C
Maximum Junction Temperature	150	$^{\circ}$ C
Maximum Lead Temperature (Soldering 20-40s) (SOT - Lead Tips Only)	260	$^{\circ}$ C

**Note:**  $\theta_{JA}$  is measured with the component mounted on an evaluation PC board in free air.

### Electrical Characteristics $T_A = -40^{\circ}$ C to $105^{\circ}$ C, $V_{IN} = 0.5V_{CC}$ , Unless Otherwise Specified

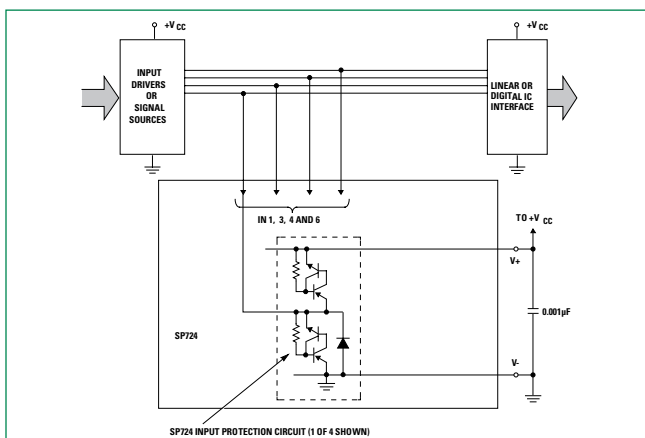
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Operating Voltage Range, $V_{SUPPLY} = [(V+) - (V-)]$ (Notes 4, 5)	$V_{SUPPLY}$		1	-	20	V
Forward Voltage Drop						
Forward Voltage Drop						
IN to V-	$V_{FWDL}$	$I_{IN} = 1A$ (Peak Pulse)	-	2	-	V
IN to V+	$V_{FWDH}$		-	2	-	V
Input Leakage Current	$I_{IN}$		-10	1	10	nA
Quiescent Supply Current	$I_{QUIESCENT}$	V+ = 20V, V- = GND	-	-	100	nA
Equivalent SCR ON Threshold		(Note 6)	-	1.1	-	V
Equivalent SCR ON Resistance		$V_{FWD}/I_{FWD}$ (Note 6)	-	1.0	-	$\Omega$
Input Capacitance	$C_{IN}$		-	3	-	pF

#### Notes:

- In automotive and other battery charging systems, the SP724 power supply lines should be externally protected for load dump and reverse battery. When the V+ and V- Pins are connected to the same supply voltage source as the device or control line under protection, a current limiting resistor should be connected in series between the external supply and the SP724 supply pins to limit reverse battery current to within the rated maximum limits.
- Bypass capacitors of typically 0.01 $\mu$ F or larger should be connected closely between the V+ and V- Pins for all applications.
- Refer to the Figure 3 graph for definitions of equivalent "SCR ON Threshold" and "SCR ON Resistance". These characteristics are given here for information to determine peak current and dissipation under EOS conditions.

### Typical Application of the SP724

Application as an Input Clamp for Over-voltage, Greater than  $1V_{BE}$  Above V+ or less than  $-1V_{BE}$  below V-



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### ESD Capability

ESD rating is dependent on the defined test standard. The evaluation results for various test standards and methods based on Figure 1 are shown in Table 1.3

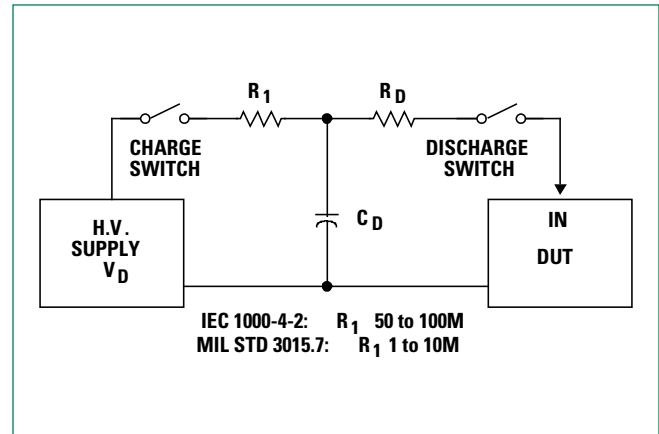
The SP724 has a Level 4 rating when tested to the IEC 61000-4-2 Human Body Model (HBM) standard and connected in a circuit in which the V+ and V- pins have a return path to ground. Level 4 specifies a required capability greater than 8kV for direct discharge and greater than 15kV for air discharge.

The "Modified" MIL-STD-3015.7 condition is defined as an "in-circuit" method of ESD testing, the V+ and V- pins have a return path to ground. The SP724 ESD capability is greater than 8kV with 100pF discharged through 1.5kΩ. By strict definition of the standard MIL-STD-3015.7 method using "pin-to-pin" device testing, the ESD voltage capability is greater than 2kV.

For the SP724 EIAJ IC121 Machine Model (MM) standard, the ESD capability is typically greater than 1.8kV with 200pF discharged through 0kΩ.

The Charged Device model is based upon the self-capacitance of the SOT-23 package through 0kΩ.

**Figure 1:**  
Electrostatic Discharge Test

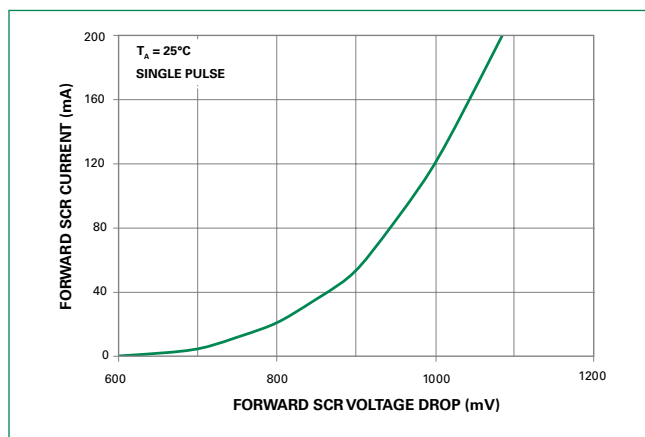


**Table 1:**  
ESD Test Conditions

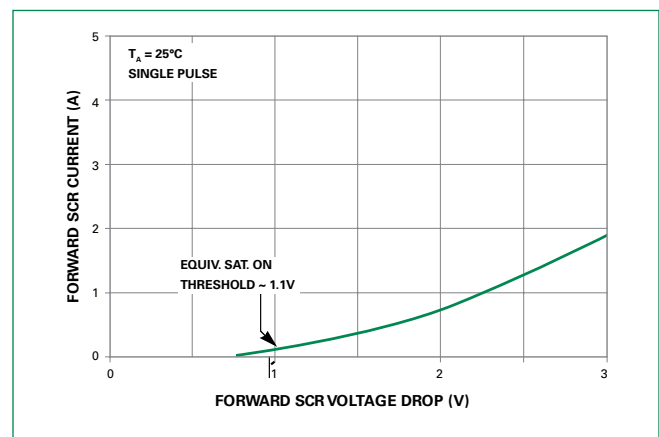
Standard	Type/Mode	$R_D$	$C_D$	$\pm V_D$
IEC 61000-4-2 (Level 4)	HBM, Air Discharge	330 $\Omega$	150pF	15kV
	HBM, Direct Discharge	330 $\Omega$	150pF	8kV
MIL-STD-3015.7	Modified HBM	1.5k $\Omega$	100pF	8kV †
	Standard HBM	1.5k $\Omega$	100pF	2kV
EIAJ IC121	Machine Model	0k $\Omega$	200pF	400V
US ESD DS 5.3	Charged Device Model	0k $\Omega$	NA	3kV

†Upper limit of laboratory test set.

**Figure 2:**  
Low Current SCR Forward Voltage Drop Curve



**Figure 3:**  
High Current SCR Forward Voltage Drop Curve



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## 3pF 8kV Diode Array

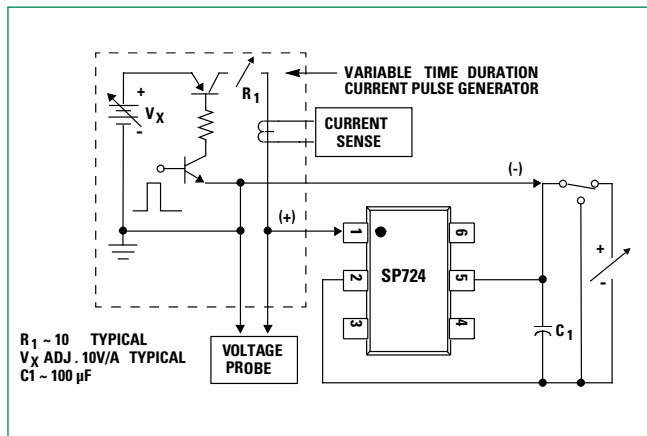
### Peak Transient Current Capability for Long Duration Surges

The peak transient current capability is inversely proportional to the width of the current pulse. Testing was done to fully evaluate the SP724's ability to withstand long duration current pulses using the circuit of Figure 4. Figure 5 shows the point of overstress as defined by increased leakage in excess of the data sheet published limits. The safe operating range of the transient peak current should be limited to no more than 75% of the measured overstress level for any given pulse width as shown in the curve of Figure 5.

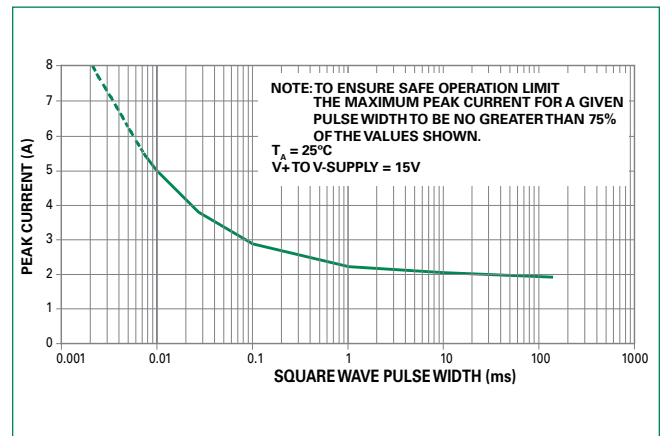
The test circuit of Figure 4 is shown with a positive pulse input. For a negative pulse input, the (-) current pulse input goes to an SP724 'IN' input pin and the (+) current pulse input goes to the SP724 V- pin. The V+ to V- supply of the SP724 must be allowed to float. (i.e., It is not tied to the ground reference of the current pulse generator.)

Note that two input pins of the SP724 may be paralleled to improve current (and ESD) capability. The sustained peak current capability is increased to nearly twice that of a single pin.

**Figure 4:**  
Typical SP724 Peak Current Test Circuit  
with a Variable Pulse Width Input



**Figure 5:**  
SP724 Typical Nonrepetitive Peak Current Pulse Capability  
Showing the Measured Point of Overstress in Amperes vs pulse width time in milliseconds

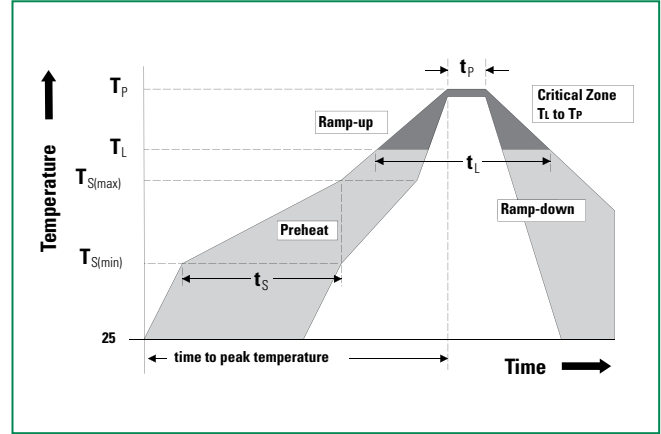


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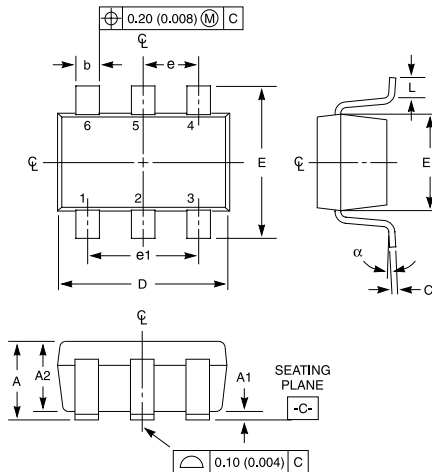
## 3pF 8kV Diode Array

### Soldering Parameters

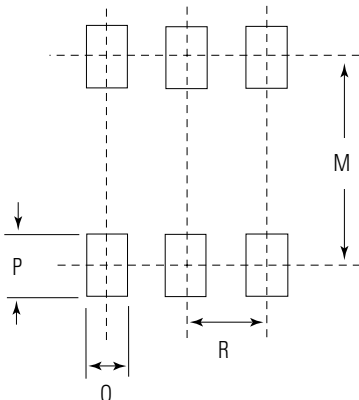
<b>Reflow Condition</b>		Pb – Free assembly
<b>Pre Heat</b>	- Temperature Min ( $T_{s(min)}$ )	150°C
	- Temperature Max ( $T_{s(max)}$ )	200°C
	- Time (min to max) ( $t_s$ )	60 – 120 secs
<b>Average ramp up rate (Liquidus) Temp (<math>T_L</math>) to peak</b>		5°C/second max
<b><math>T_{s(max)}</math> to <math>T_L</math> - Ramp-up Rate</b>		5°C/second max
<b>Reflow</b>	- Temperature ( $T_L$ ) (Liquidus)	217°C
	- Temperature ( $t_L$ )	60 – 150 seconds
<b>Peak Temperature (<math>T_p</math>)</b>		260 <sup>+0/-5</sup> °C
<b>Time within 5°C of actual peak Temperature (<math>t_p</math>)</b>		30 seconds
<b>Ramp-down Rate</b>		5°C/second max
<b>Time 25°C to peak Temperature (<math>T_p</math>)</b>		8 minutes Max.
<b>Do not exceed</b>		260°C



### Package Dimensions – Small Outline Transistor Plastic Packages (SOT23-6)



#### Recommended Solder Pad Layout



Package	SOT23-6				Notes
Pins	6				
JEDEC	MO-178				Notes
	Millimeters		Inches		
	Min	Max	Min	Max	
A	0.900	1.450	0.035	0.057	-
A1	0.000	0.150	0.000	0.006	-
A2	0.900	1.300	0.035	0.051	-
b	0.300	0.500	0.0118	0.0196	-
C	0.080	0.220	0.0031	0.009	-
D	2.800	3.000	0.11	0.118	3
E	2.600	3.000	0.102	0.118	-
E1	1.500	1.750	0.06	0.069	3
e	0.95 Ref		0.0374 ref		-
e1	1.9 Ref		0.0748 Ref		-
L	0.100	0.600	0.004	0.023	4,5
N	6		6		6
a	0°	10°	0°	10°	-
M	2.590		0.102		-
O	0.690		.027 TYP		-
P	0.990		.039 TYP		-
R	0.950		0.038		-

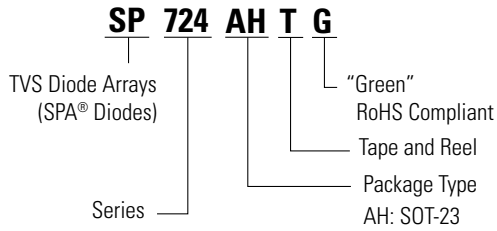
#### Notes:

1. Dimensioning and tolerances per ANSI 14.5M-1982.
2. Package conforms to EIAJ SC-74 (1992).
3. Dimensions D and E1 are exclusive of mold flash, protrusions, or gate burrs.
4. Footlength L measured at reference to seating plane.
5. "L" is the length of flat foot surface for soldering to substrate.
6. "N" is the number of terminal positions.
7. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

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### Part Numbering System



### Product Characteristics

<b>Lead Plating</b>	Matte Tin
<b>Lead Material</b>	Copper Alloy
<b>Lead Coplanarity</b>	0.004 inches (0.102mm)
<b>Substitute Material</b>	Silicon
<b>Body Material</b>	Molded Epoxy
<b>Flammability</b>	UL 94 V-0

**Notes:**

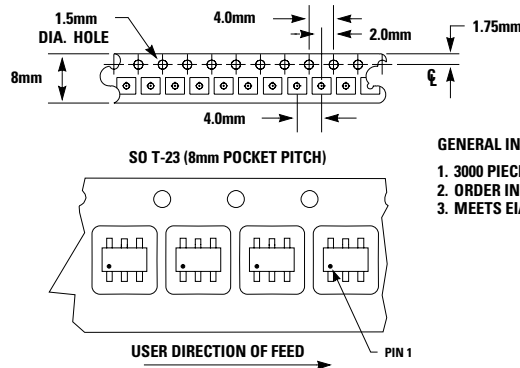
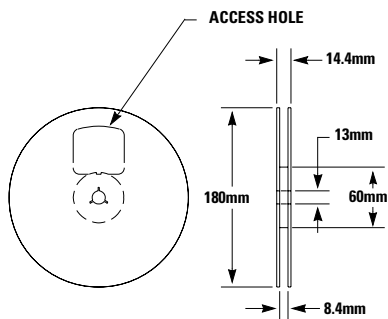
1. All dimensions are in millimeters.
2. Dimensions include solder plating.
3. Dimensions are exclusive of mold flash & metal burr.
4. Blo is facing up for mold and facing down for trim/form, i.e. reverse trim/form.
5. Package surface matte finish VDI 11-13.

### Ordering Information

Part Number	Temp. Range (°C)	Package	Marking	Min. Order Qty.
SP724AHTG	-40 to 105	Tape and Reel	724G	3000

### Embossed Carrier Tape & Reel Specification – SOT23-6

8mm TAPE AND REEL



**GENERAL INFORMATION**

1. 3000 PIECES PER REEL.
2. ORDER IN MULTIPLES OF FULL REELS ONLY.
3. MEETS EIA-481 REVISION "A" SPECIFICATIONS.

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